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Stocking Distributor

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[Vishay/Siliconix](#)
[SIB800EDK-T1-GE3](#)

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New Product



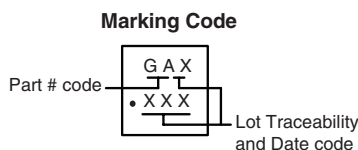
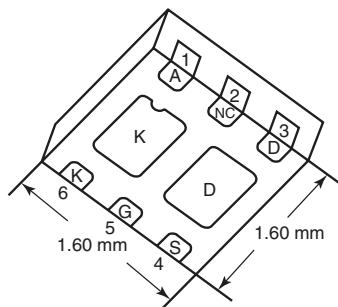
SiB800EDK
Vishay Siliconix

N-Channel 20-V (D-S) MOSFET with Trench Schottky Diode

PRODUCT SUMMARY			
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^a	Q _g (Typ.)
20	0.225 at V _{GS} = 4.5 V	1.5	1.1 nC
	0.270 at V _{GS} = 2.5 V	1.5	
	0.345 at V _{GS} = 1.8 V	1.5	
	0.960 at V _{GS} = 1.5 V	0.5	

SCHOTTKY PRODUCT SUMMARY		
V _{KA} (V)	V _f (V) Diode Forward Voltage	I _F (A) ^a
30	0.29 at 10 mA	0.4

PowerPAK SC75-6L-Dual



Ordering Information: SIB800EDK-T1-GE3 (Lead (Pb)-free and Halogen-free)

FEATURES

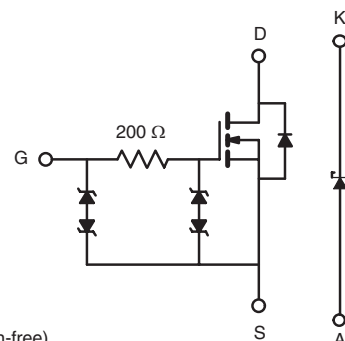
- Halogen-free According to IEC 61249-2-21
- LITTLE FOOT[®] Plus Schottky Power MOSFET
- New Thermally Enhanced PowerPAK[®] SC-75 Package
 - Small Footprint Area
 - Low On-Resistance
 - Thin 0.75 mm profile
- Typical ESD Protection 2800 V



RoHS
COMPLIANT
HALOGEN
FREE

APPLICATIONS

- Portable Devices
- DC/DC Converters



ABSOLUTE MAXIMUM RATINGS T _A = 25 °C, unless otherwise noted				
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage (MOSFET)	V _{DS}	20	V	
Reverse Voltage (Schottky)	V _{KA}	30		
Gate-Source Voltage (MOSFET)	V _{GS}	± 6		
Continuous Drain Current (T _J = 150 °C) (MOSFET)	T _C = 25 °C	1.5 ^a	A	
	T _C = 70 °C	1.5 ^a		
	T _A = 25 °C	1.5 ^{a, b, c}		
	T _A = 70 °C	1.3 ^{b, c}		
Pulsed Drain Current (MOSFET)	I _{DM}	4	A	
Continuous Source-Drain Diode Current (MOSFET Diode Conduction)	T _C = 25 °C	1.5 ^a		
	T _A = 25 °C	0.9 ^{b, c}		
Average Forward Current (Schottky)	I _F	0.4 ^b		
Pulsed Forward Current (Schottky)	I _{FM}	0.8		
Maximum Power Dissipation (MOSFET)	T _C = 25 °C	3.1	W	
	T _C = 70 °C	2		
	T _A = 25 °C	1.1 ^{b, c}		
	T _A = 70 °C	0.7 ^{b, c}		
Maximum Power Dissipation (Schottky)	T _C = 25 °C	3.1		
	T _C = 70 °C	2		
	T _A = 25 °C	1.1 ^{b, c}		
	T _A = 70 °C	0.7 ^{b, c}		
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature) ^{d, e}		260		

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THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient (MOSFET) ^{b, f}	$t \leq 5 \text{ s}$	R_{thJA}	90	115	°C/W
Maximum Junction-to-Case (Drain) (MOSFET)	Steady State	R_{thJC}	32	40	
Maximum Junction-to-Ambient (Schottky) ^{b, f}	$t \leq 5 \text{ s}$	R_{thJA}	90	115	
Maximum Junction-to-Case (Drain) (Schottky)	Steady State	R_{thJC}	32	40	

Notes:

a. Package limited.

b. Surface Mounted on 1" x 1" FR4 board.

c. $t = 5 \text{ s}$.

d. See Solder Profile (www.vishay.com/ppg?73257). The PowerPAK SC-75 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.

e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.

f. Maximum under Steady State conditions is 125 °C/W.

SPECIFICATIONS $T_J = 25\text{ }^{\circ}\text{C}$, unless otherwise noted						
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0\text{ V}$, $I_D = 250\text{ }\mu\text{A}$	20			V
V_{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	$I_D = 250\text{ }\mu\text{A}$		21		mV/ $^{\circ}\text{C}$
$V_{GS(th)}$ Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			- 2.3		
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}$, $I_D = 250\text{ }\mu\text{A}$	0.4		1.0	V
Gate-Source Leakage	I_{GSS}	$V_{DS} = 0\text{ V}$, $V_{GS} = \pm 3\text{ V}$			± 1	μA
		$V_{DS} = 0\text{ V}$, $V_{GS} = \pm 6\text{ V}$			± 1	mA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 20\text{ V}$, $V_{GS} = 0\text{ V}$			1	μA
		$V_{DS} = 20\text{ V}$, $V_{GS} = 0\text{ V}$, $T_J = 55\text{ }^{\circ}\text{C}$			10	
On-State Drain Current ^a	$I_{D(on)}$	$V_{DS} \geq 5\text{ V}$, $V_{GS} = 4.5\text{ V}$	4			A
Drain-Source On-State Resistance ^a	$R_{DS(on)}$	$V_{GS} = 4.5\text{ V}$, $I_D = 1.6\text{ A}$		0.183	0.225	Ω
		$V_{GS} = 2.5\text{ V}$, $I_D = 1.5\text{ A}$		0.220	0.270	
		$V_{GS} = 1.8\text{ V}$, $I_D = 1.3\text{ A}$		0.275	0.345	
		$V_{GS} = 1.5\text{ V}$, $I_D = 0.3\text{ A}$		0.320	0.960	
Forward Transconductance ^a	g_{fs}	$V_{DS} = 10\text{ V}$, $I_D = 1.6\text{ A}$		3.5		S
Dynamic ^b						
Total Gate Charge	Q_g	$V_{DS} = 10\text{ V}$, $V_{GS} = 4.5\text{ V}$, $I_D = 1.7\text{ A}$		1.1	1.7	nC
Gate-Source Charge	Q_{gs}			0.2		
Gate-Drain Charge	Q_{gd}			0.1		
Gate Resistance	R_g	$f = 1\text{ MHz}$		200		Ω
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = 10\text{ V}$, $R_L = 7.7\text{ }\Omega$ $I_D \cong 1.3\text{ A}$, $V_{GEN} = 4.5\text{ V}$, $R_g = 1\text{ }\Omega$		20	30	ns
Rise Time	t_r			12	20	
Turn-Off DelayTime	$t_{d(off)}$			70	105	
Fall Time	t_f			20	30	
Drain-Source Body Diode Characteristics						
Continuous Source-Drain Diode Current	I_S	$T_C = 25\text{ }^{\circ}\text{C}$			1.5	A
Pulse Diode Forward Current	I_{SM}				4	
Body Diode Voltage	V_{SD}	$I_S = 1.3\text{ A}$, $V_{GS} = 0\text{ V}$		0.9	1.2	V

Notes:

a. Pulse test; pulse width $\leq 300 \text{ } \mu\text{s}$, duty cycle $\leq 2 \text{ } \%$.

b. Guaranteed by design, not subject to production testing.

New Product

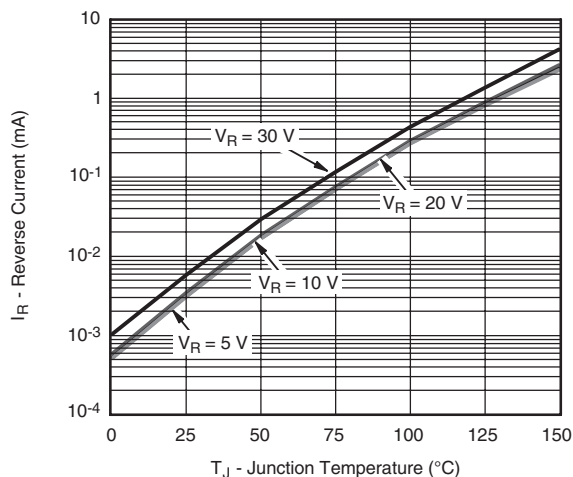


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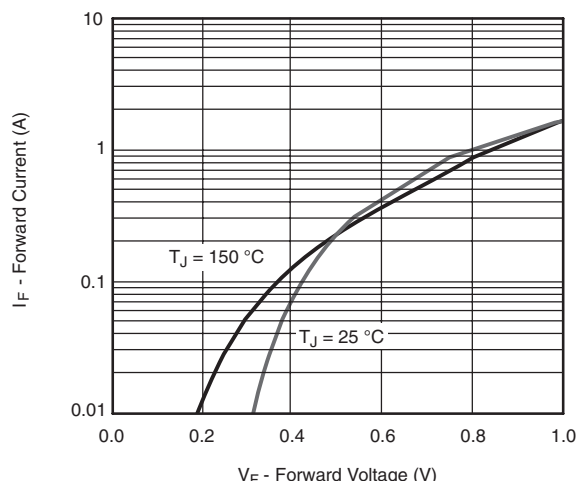
SCHOTTKY SPECIFICATIONS $T_J = 25\text{ }^{\circ}\text{C}$, unless otherwise noted						
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Forward Voltage Drop	V_F	$I_F = 10\text{ mA}$		0.23	0.29	V
		$I_F = 10\text{ mA}$, $T_J = 125\text{ }^{\circ}\text{C}$		0.11	0.14	
		$I_F = 0.1\text{ A}$		0.32	0.38	
Maximum Reverse Leakage Current	I_{rm}	$V_r = 20\text{ V}$		0.005	0.050	mA
		$V_r = 20\text{ V}$, $T_J = 85\text{ }^{\circ}\text{C}$		0.150	1.5	
Junction Capacitance	C_T	$V_r = 15\text{ V}$		16		pF

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

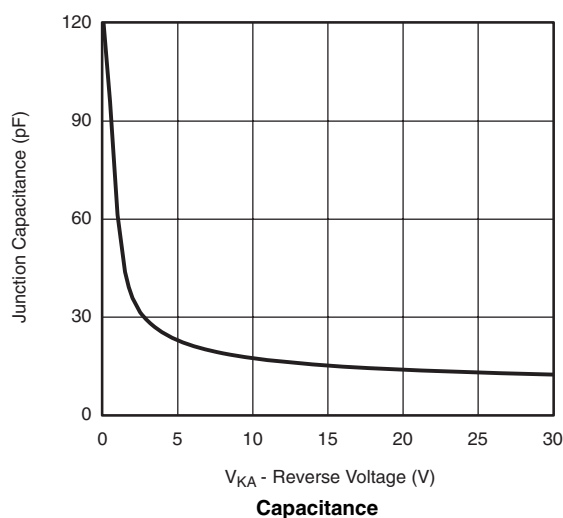
SCHOTTKY TYPICAL CHARACTERISTICS $T_A = 25\text{ }^{\circ}\text{C}$, unless otherwise noted



Reverse Current vs. Junction Temperature



Forward Voltage Drop



Capacitance

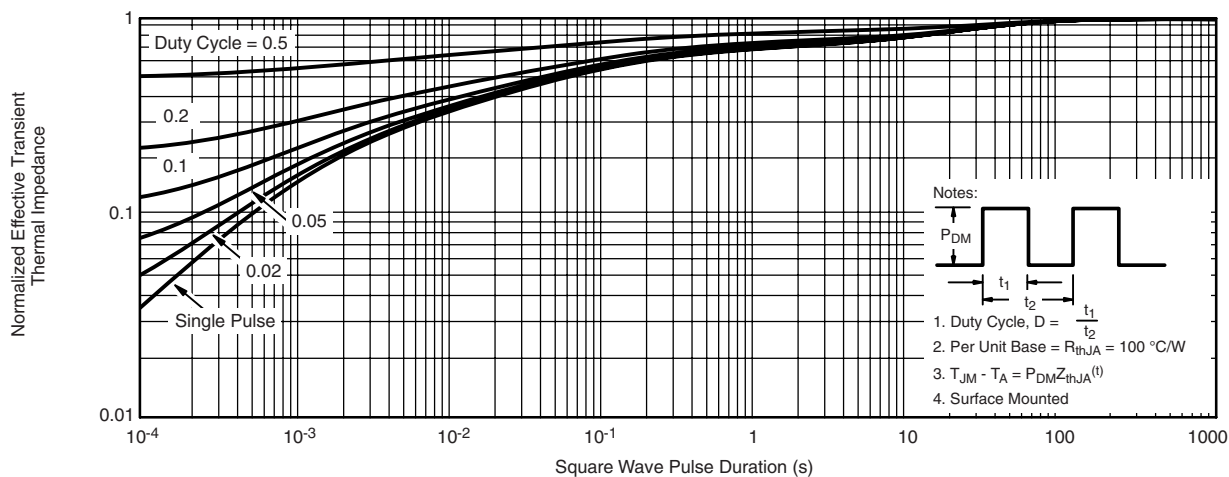
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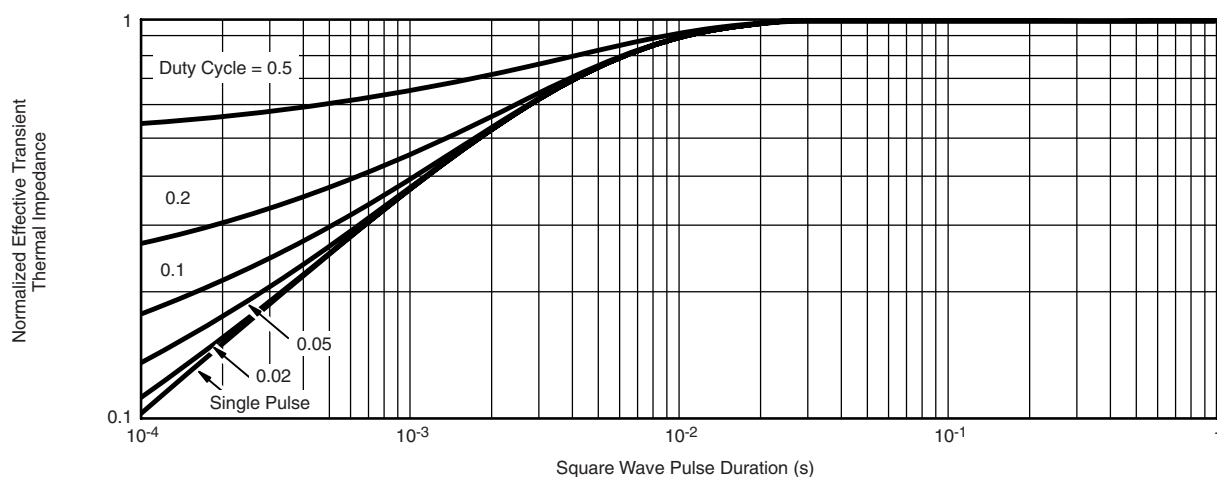
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Normalized Thermal Transient Impedance, Junction-to-Ambient



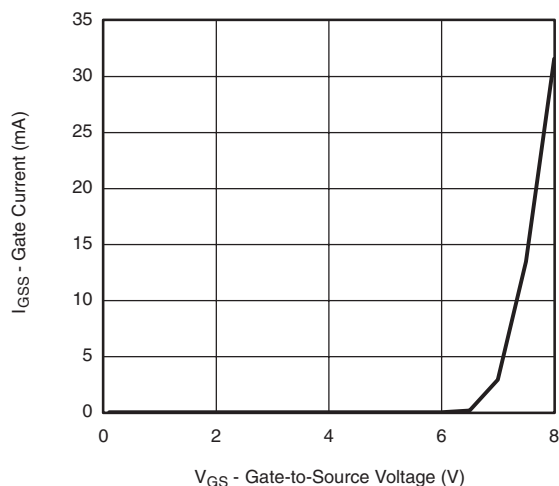
Normalized Thermal Transient Impedance, Junction-to-Case

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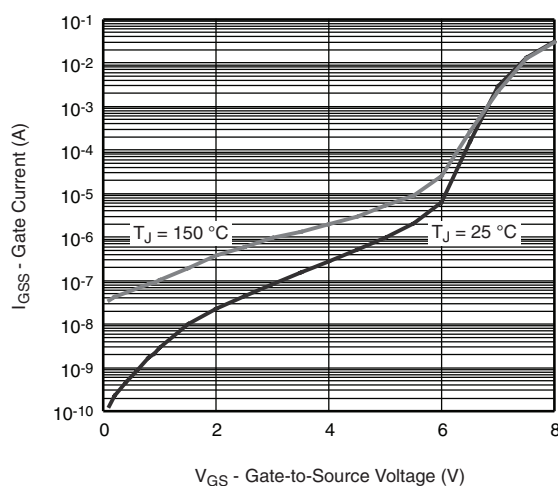


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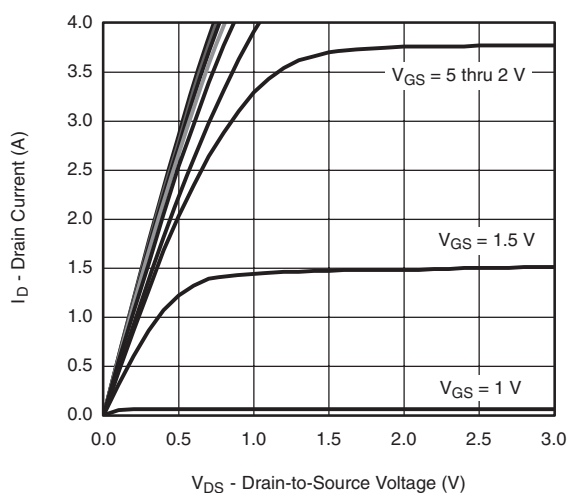
MOSFET TYPICAL CHARACTERISTICS $T_A = 25^\circ\text{C}$, unless otherwise noted



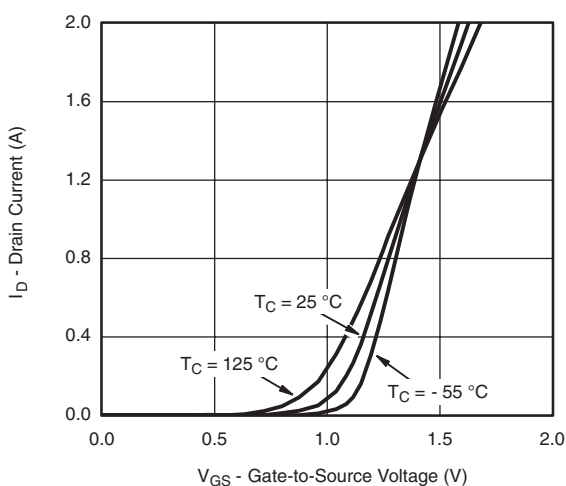
Gate Current vs. Gate-to-Source Voltage



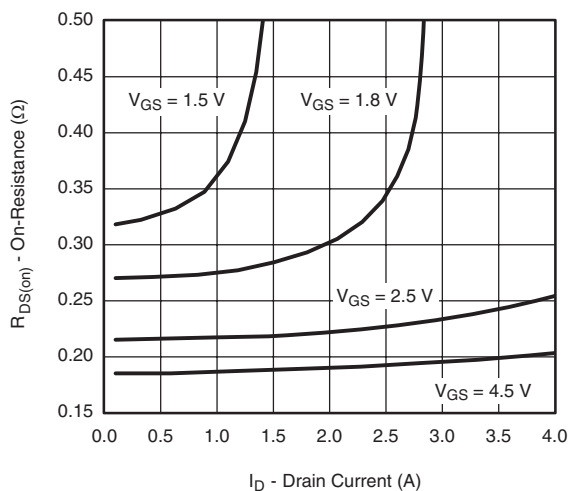
Gate Current vs. Gate-to-Source Voltage



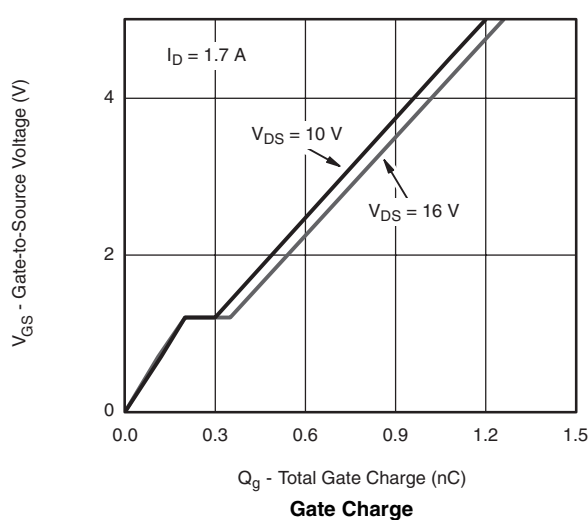
Output Characteristics



Transfer Characteristics



On-Resistance vs. Drain Current



Gate Charge

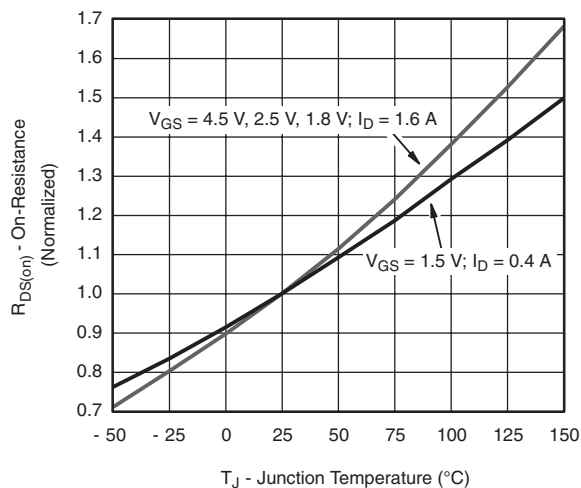
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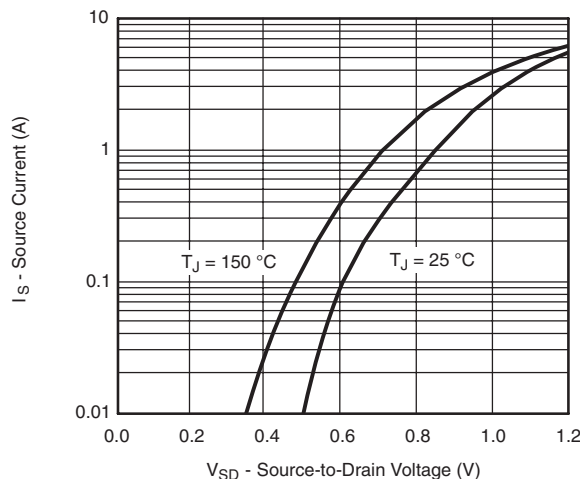
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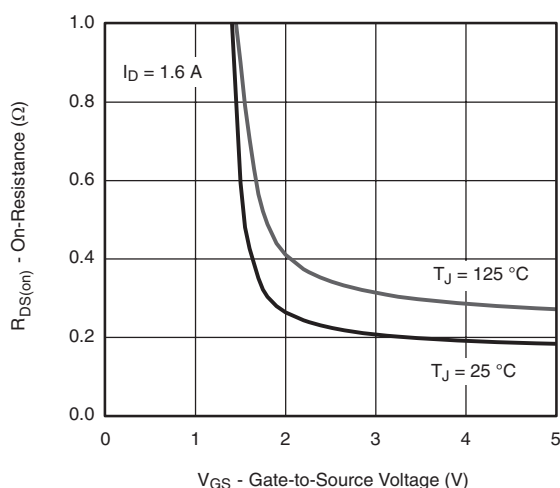
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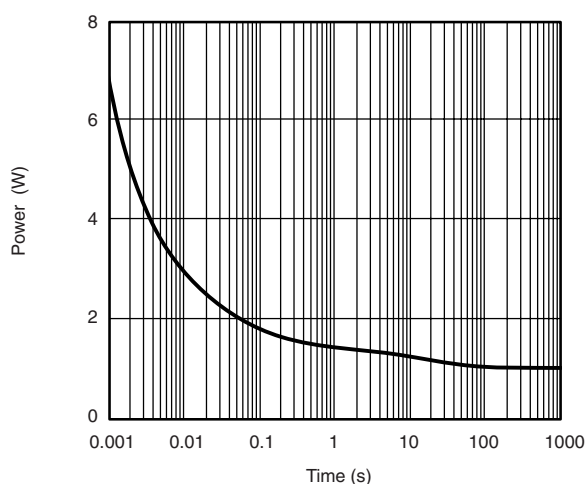
Normalized On-Resistance vs. Junction Temperature



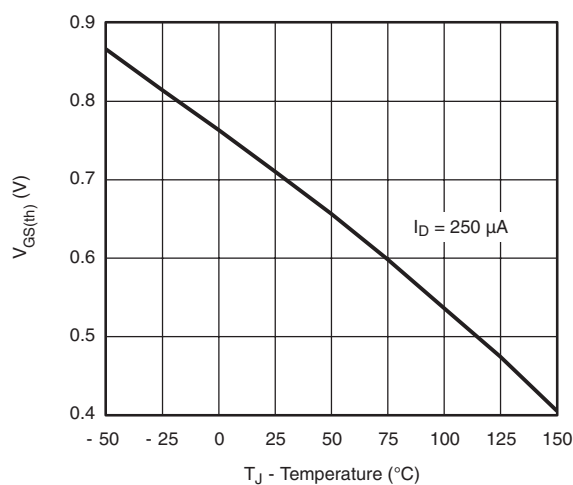
Source-Drain Diode Forward Voltage



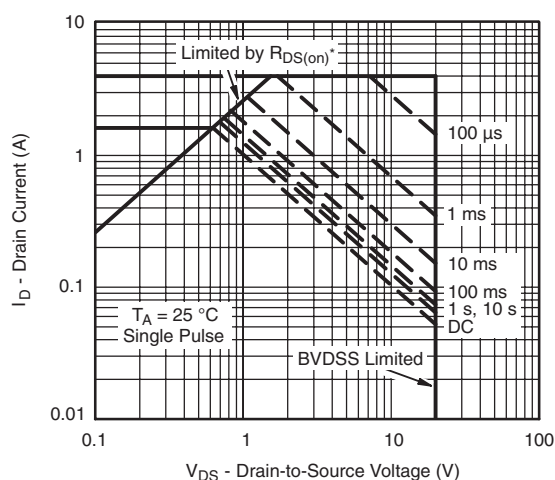
On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient



Threshold Voltage



* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

Safe Operating Area, Junction-to-Ambient

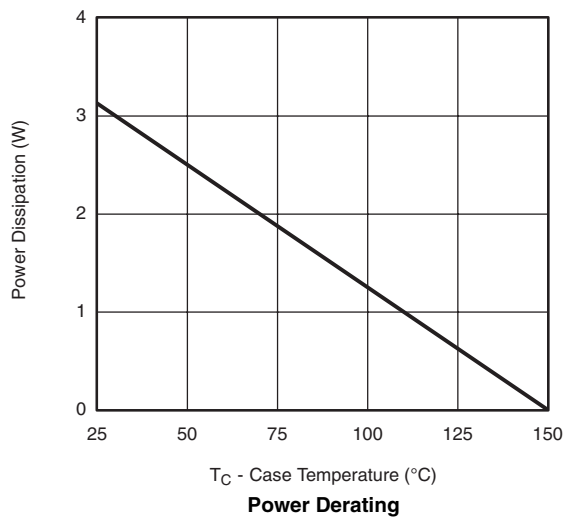
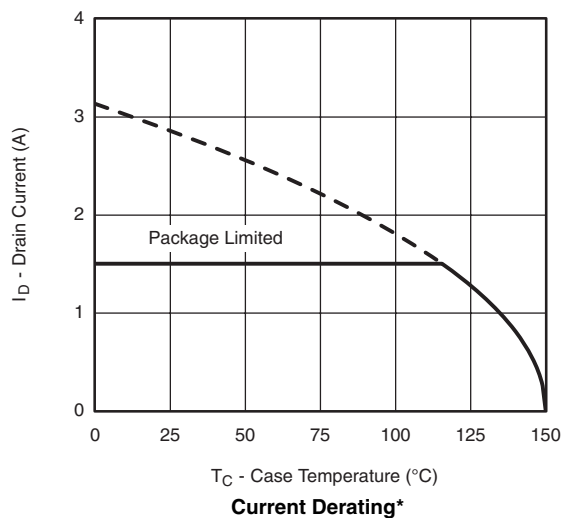
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MOSFET TYPICAL CHARACTERISTICS $T_A = 25\text{ }^{\circ}\text{C}$, unless otherwise noted



* The power dissipation P_D is based on $T_{J(\max)} = 150\text{ }^{\circ}\text{C}$, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

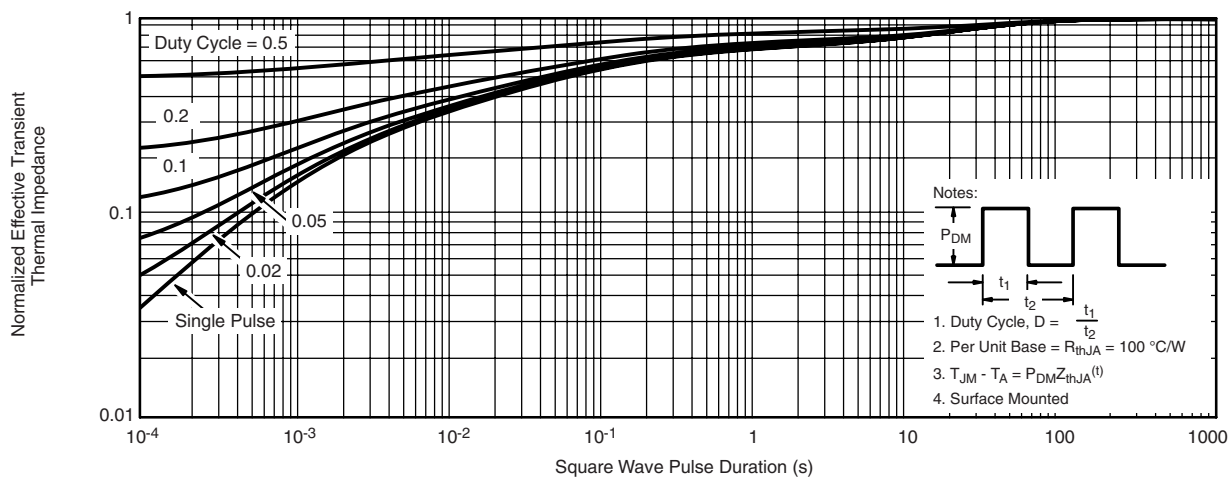
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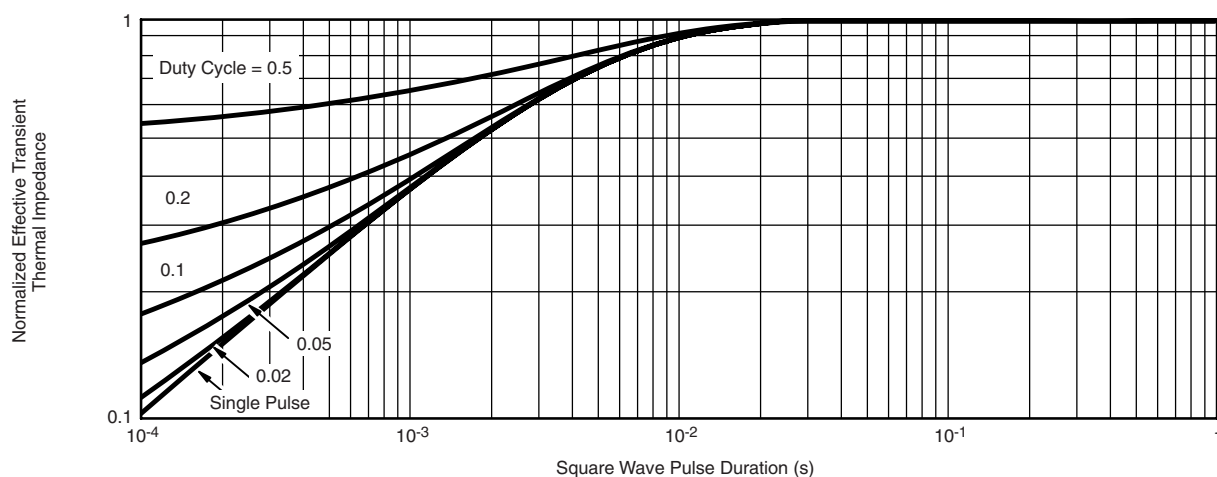
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Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?68860.



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